## 700 MHz, -3 dB Bandwidth; Dual SPDT Analog Switch

## DESCRIPTION

DG2723 is a low $R_{\text {ON }}$, high bandwidth analog switch configured in dual SPDT. It achieves $5.5 \Omega$ switch on resistance, greater than $700 \mathrm{MHz}-3 \mathrm{~dB}$ bandwidth with 5 pF load, and a channel to channel crosstalk at -36 dB and isolation at -29 dB . Fabricated with high density sub micro CMOS process, the DG2723 provides low parasitic capacitance, handles bidirectional signal flow with minimized phase distortion. Guaranteed 1.3 V logic high threshold makes it possible to interface directly with low voltage MCUs. The DG2723 is designed for a wide range of operating voltages from 2.7 V to 5.5 V that can be driven directly from one cell Li-ion battery. On-chip protection circuit protects again fault events when signals at "com" pins goes beyond $\mathrm{V}+$.
Latch up current is 500 mA , as per JESD78, and its ESD tolerance exceeds 5 kV . Packaged in ultra small miniQFN-10 ( $1.4 \mathrm{~mm} \times 1.8 \mathrm{~mm} \times 0.55 \mathrm{~mm}$ ), it is ideal for portable high speed mix signal switching application.
As a committed partner to the community and the environment, Vishay Siliconix manufactures this product with lead (Pb)-free device termination. The miniQFN-10 package has a nickel-palladium-gold device termination and is represented by the lead ( Pb )-free "-E4" suffix to the ordering part number. The nickel-palladium-gold device terminations meet all JEDEC ${ }^{\circledR}$ standards for reflow and MSL rating. As a further sign of Vishay Siliconix's commitment, the DG2723 is fully RoHS complaint.

## FEATURES

- Wide operation voltage range
- Low on-resistance, $5.5 \Omega$ (typical at 3 V )
- Low capacitance, 5.6 pF (typical)
- -3 dB high bandwidth with 5 pF load: 700 MHz (typical)
- Low bit to bit skew: 40 pS (typical)
- Low power consumption
- Low logic threshold: V
- Power down protection: D+/D- pins can tolerate up to 5.5 V when $\mathrm{V}+=0 \mathrm{~V}$
- Logic (S+ and S-) above V+ tolerance
- 5 kV ESD protection (HBM)
- Latch-up current 500 mA per JESD78
- Lead (Pb)-free low profile miniQFN-10 (1.4 mm x 1.8 mm x 0.55 mm )
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912


## APPLICATIONS

- Cellular phones
- Portable media players
- PDA
- Digital camera
- GPS
- Notebook computer
- TV, monitor, and set top box


## FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION




Device marking: Tx for DG2723 x = Date/Lot traceability code

DG2723

| ORDERING INFORMATION |  |  |  |
| :---: | :---: | :---: | :---: |
| TEMP. RANGE | PACKAGE | PART NUMBER |  |
| $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ | miniQFN-10 | DG2723DN-T1-E4 |  |


| TRUTH TABLE |  |  |
| :---: | :---: | :---: |
| S+ (PIN 8) | S- (PIN 10) | FUNCTION |
| $X$ | 0 | D- = HSD1- |
| $X$ | 1 | $\mathrm{D}-=$ HSD2- |
| 0 | X | $\mathrm{D}+=$ HSD1+ |
| 1 | X | $\mathrm{D}+=$ HSD2 + |


| PIN DESCRIPTIONS |  |
| :---: | :---: |
| PIN NAME | DESCRIPTION |
| S+ | Select Input for D+ |
| S- | Select Input for $\mathrm{D}-$ |
| $\mathrm{HSD}_{ \pm}, \mathrm{HSD} 2 \pm, \mathrm{D}_{ \pm}$ | Data Port |


| ABSOLUTE MAXIMUM RATINGS ( $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$, unless otherwise noted) |  |  |  |
| :---: | :---: | :---: | :---: |
| PARAMETER |  | LIMIT | UNIT |
| Reference to GND | $\mathrm{V}+$ | -0.3 to 6 | V |
|  | S+, S-, D $\pm$, HSD1 $\pm$, HSD2 $\pm{ }^{\text {a }}$ | -0.3 to (V+ + 0.3) |  |
| Current (Any Terminal except S+, S-, D $\pm$, HSD1 $\pm$, HSD2 $\pm$ ) |  | 30 | mA |
| Continuous Current (S+, S-, D $\pm$, HSD1 $\pm$, HSD2 $\pm$ ) |  | $\pm 250$ |  |
| Peak Current (Pulsed at $1 \mathrm{~ms}, 10$ \% Duty Cycle) |  | $\pm 500$ |  |
| Storage Temperature (D Suffix) |  | -65 to 150 | ${ }^{\circ} \mathrm{C}$ |
| Power Dissipation (Packages) ${ }^{\text {b }}$ | miniQFN-10 ${ }^{\text {c }}$ | 208 | mW |
| ESD (Human Body Model) |  | 5 | kV |
| Latch-up (Current Injection) |  | 500 | mA |

## Notes

a. Signals on $\mathrm{S}+, \mathrm{S}-, \mathrm{D} \pm, \mathrm{HSD} 1 \pm, \mathrm{HSD} 2 \pm$ exceeding $\mathrm{V}+$ will be clamped by internal diodes. Limit forward diode current to maximum current ratings.
b. All leads welded or soldered to PC board.
c. Derate $2.6 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ above $70^{\circ} \mathrm{C}$.

| SPECIFICATIONS (V+ = 3 V ) |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| PARAMETER | SYMBOL | TEST CONDITIONS OTHERWISE UNLESS SPECIFIED | TEMP. ${ }^{\text {a }}$ | $\begin{gathered} \text { LIMITS } \\ -40^{\circ} \mathrm{C} \text { to } 85^{\circ} \mathrm{C} \end{gathered}$ |  |  | UNIT |
|  |  |  |  | MIN. ${ }^{\text {b }}$ | TYP. ${ }^{\text {c }}$ | MAX. ${ }^{\text {b }}$ |  |
| Analog Switch |  |  |  |  |  |  |  |
| Analog Signal Range ${ }^{\text {d }}$ | $\mathrm{V}_{\text {ANALOG }}$ | $\mathrm{R}_{\mathrm{DS} \text { (on) }}$ | Full | 0 | - | V+ | V |
| On-Resistance | $\mathrm{R}_{\mathrm{DS} \text { (on) }}$ | $\mathrm{V}_{+}=3 \mathrm{~V}, \mathrm{I}_{\mathrm{D}_{ \pm}}=8 \mathrm{~mA}, \mathrm{~V}_{\mathrm{HSD} 1 / 2 \pm}=0.4 \mathrm{~V}$ | Room | - | 5.5 | 8 | $\Omega$ |
|  |  |  | Full | - | - | 9 |  |
| On-Resistance Match ${ }^{\text {d }}$ | $\Delta \mathrm{R}_{\text {ON }}$ | $\mathrm{V}_{+}=3 \mathrm{~V}, \mathrm{I}_{\mathrm{D}_{ \pm}}=8 \mathrm{~mA}, \mathrm{~V}_{\mathrm{HSD} 1 / 2 \pm}=0.4 \mathrm{~V}$ | Room | - | 0.8 | - |  |
| On-Resistance Resistance Flatness ${ }^{\text {d }}$ | RON Flatness | $\mathrm{V}+=3 \mathrm{~V}, \mathrm{I}_{\mathrm{D} \pm}=8 \mathrm{~mA}, \mathrm{~V}_{\mathrm{HSD} 1 / 2 \pm}=0 \mathrm{~V}, 1 \mathrm{~V}$ | Room | - | 2 | - |  |
| Switch Off Leakage Current | ${ }^{\text {(off) }}$ | $\begin{gathered} \mathrm{V}_{+}=4.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{HSD} 1 / 2 \pm}=0.3 \mathrm{~V}, 3 \mathrm{~V}, \\ \mathrm{~V}_{\mathrm{D} \pm}=3 \mathrm{~V}, 0.3 \mathrm{~V} \end{gathered}$ | Full | -100 | - | 100 | nA |
| Channel On Leakage Current | ${ }^{(o n)}$ | $\begin{gathered} \mathrm{V}_{+}=4.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{HSD} 1 / 2 \pm}=0.3 \mathrm{~V}, 4 \mathrm{~V}, \\ \mathrm{~V}_{\mathrm{D} \pm}=4 \mathrm{~V}, 0.3 \mathrm{~V} \end{gathered}$ | Full | -200 | - | 200 |  |
| Digital Control |  |  |  |  |  |  |  |
| Input Voltage High | $\mathrm{V}_{\text {INH }}$ | $\mathrm{V}+=3 \mathrm{~V}$ to 3.6 V | Full | 1.3 | - | - | V |
|  |  | $\mathrm{V}+=4.3 \mathrm{~V}$ | Full | 1.5 | - | - |  |
| Input Voltage Low | $\mathrm{V}_{\text {INL }}$ | $\mathrm{V}+=3 \mathrm{~V}$ to 4.3 V | Full | - | - | 0.5 |  |
| Input Capacitance | $\mathrm{C}_{\text {IN }}$ |  | Full | - | 6.5 | - | pF |
| Input Current | $\mathrm{l}_{\mathrm{INL}}$ or $\mathrm{l}_{\mathrm{INH}}$ | $\mathrm{V}_{\text {IN }}=0$ or $\mathrm{V}_{+}$ | Full | -1 | - | 1 | $\mu \mathrm{A}$ |


| SPECIFICATIONS (V+ = 3 V ) |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| PARAMETER | SYMBOL | TEST CONDITIONS OTHERWISE UNLESS SPECIFIED | TEMP. ${ }^{\text {a }}$ | LIMITS <br> $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ |  |  | UNIT |
|  |  |  |  | MIN. ${ }^{\text {b }}$ | TYP. ${ }^{\text {c }}$ | MAX. ${ }^{\text {b }}$ |  |
| Dynamic Characteristics |  |  |  |  |  |  |  |
| Break-Before-Make Time ${ }^{\text {e, }} \mathrm{d}$ | $t_{\text {BBM }}$ | $\begin{gathered} \mathrm{V}+=3 \mathrm{~V}, \mathrm{~V}_{\mathrm{D} 1 / 2 \pm}=1.5 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=50 \Omega, \\ \mathrm{C}_{\mathrm{L}}=35 \mathrm{pF} \end{gathered}$ | Room | - | 5 | - | ns |
|  |  |  | Full |  |  |  |  |
| S-, S+ Turn-On Time ${ }^{\text {e }, ~ d ~}$ | $\mathrm{t}_{\mathrm{ON}}$ |  | Room | - | - | 30 |  |
|  |  |  | Full |  |  |  |  |
| S-, S+ Turn-Off Time e, d | $\mathrm{t}_{\text {OFF }}$ |  | Room | - | - | 25 |  |
|  |  |  | Full |  |  |  |  |
| Charge Injection ${ }^{\text {d }}$ | QinJ | $\mathrm{C}_{\mathrm{L}}=1 \mathrm{nF}, \mathrm{R}_{\mathrm{GEN}}=0 \Omega, \mathrm{~V}_{\mathrm{GEN}}=0 \mathrm{~V}$ | Room | - | 3 | - | pC |
| Off-Isolation ${ }^{\text {d }}$ | OIRR | $\begin{gathered} \mathrm{V}+=3 \mathrm{~V} \text { to } 3.6 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF}, \\ \mathrm{f}=240 \mathrm{MHz} \end{gathered}$ |  | - | -29 | - | dB |
| Crosstalk ${ }^{\text {d }}$ | $\mathrm{X}_{\text {TALK }}$ |  |  | - | -36 | - |  |
| Bandwidth ${ }^{\text {d }}$ | BW | $\mathrm{V}+=3 \mathrm{~V}$ to $3.6 \mathrm{~V}, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF}, \mathrm{R}_{\mathrm{L}}=50 \Omega,-3 \mathrm{~dB}$ |  | - | 700 | - | MHz |
| Channel-Off Capacitance ${ }^{\text {d }}$ | $\mathrm{C}_{\mathrm{D1} \mathrm{ \pm} \text { (off) }}$ | $\mathrm{V}+=3.3 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}$ |  | - | 2.5 | - | pF |
|  | $\mathrm{C}_{\mathrm{D} 2 \pm \text { (off) }}$ |  |  | - | 2.5 | - |  |
| Channel-On Capacitance ${ }^{\text {d }}$ | $\mathrm{C}_{\mathrm{D} \pm \text { (off) }}$ |  |  | - | 2.5 | - |  |
|  | $\mathrm{C}_{\mathrm{D} \mathrm{ \pm} \text { (on) }}$ |  |  | - | 6.5 | - |  |
| Channel-to-Channel Skew ${ }^{\text {d }}$ | $\mathrm{t}_{\mathrm{SK}(0)}$ | $\mathrm{V}+=3 \mathrm{~V}$ to $3.6 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF}$ |  | - | 50 | - | ps |
| Skew Off Opposite Transitions of the Same Output ${ }^{d}$ | ${ }^{\text {SKK(p) }}$ |  |  | - | 20 | - |  |
| Total Jitter ${ }^{\text {d }}$ | t |  |  | - | 200 | - |  |
| Power Supply |  |  |  |  |  |  |  |
| Power Supply Range | V+ |  |  | 2.6 | - | 5.5 | V |
| Power Supply Current | I+ | $\mathrm{V}_{\text {IN }}=0 \mathrm{~V}$, or $\mathrm{V}_{+}$ | Full | - | - | 2 | $\mu \mathrm{A}$ |

## Notes

a. Room $=25^{\circ} \mathrm{C}$, Full $=$ as determined by the operating suffix.
b. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this datasheet.
c. Typical values are for design aid only, not guaranteed nor subject to production testing.
d. Guarantee by design, not subjected to production test.
e. $\mathrm{V}_{\mathrm{IN}}=$ input voltage to perform proper function.
f. Crosstalk measured between channels.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS $\left(\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}\right.$, unless otherwise noted)

$R_{\text {ON }}$ vs. $\mathbf{V}_{\mathrm{D}}$ and Single Supply Voltage


Ron vs. Analog Voltage and Temperature


Ron vs. Analog Voltage and Temperature

$R_{\text {ON }}$ vs. Analog Voltage and Temperature


Ron $_{\text {on }}$ vs. Analog Voltage and Temperature


Ron vs. Analog Voltage and Temperature

TYPICAL CHARACTERISTICS $\left(\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}\right.$, unless otherwise noted)


Supply Current vs. Input Switching Frequency


Switching Threshold vs. Supply Voltage


Off-Isolation, $\mathrm{V}_{+}=3.3 \mathbf{V}$


Leakage Current vs. Temperature


Gain vs. Frequency, $\mathrm{V}_{+}=3.3 \mathrm{~V}$


Crosstalk, $\mathbf{V}_{+}=3.3 \mathbf{V}$

## TEST CIRCUITS


$C_{\mathrm{L}}$ (includes fixture and stray capacitance)

$$
v_{\text {OUT }}=D \pm\left(\frac{R_{L}}{R_{L}+R_{\text {ON }}}\right)
$$



Logic "1" = Switch on
Logic input waveforms inverted for switches that have the opposite logic sense.

Fig. 1 - Switching Time


Fig. 2 - Break-Before-Make Interval



IN depends on switch configuration: input polarity determined by sense of switch.

Fig. 3 - Charge Injection

## TEST CIRCUITS



Fig. 4 - Off-Isolation


Fig. 5 - Channel Off/On Capacitance

MINI QFN-10L CASE OUTLINE


| DIM | MILLIMETERS |  |  | INCHES |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | MIN. | NAM. | MAX. | MIN. | NAM. | MAX. |
| A | 0.45 | 0.55 | 0.60 | 0.0177 | 0.0217 | 0.0236 |
| A1 | 0.00 | - | 0.05 | 0.000 | - | 0.002 |
| b | 0.15 | 0.20 | 0.25 | 0.006 | 0.008 | 0.010 |
| c | 0.150 or $0.127 \mathrm{REF}^{(1)}$ |  |  | 0.006 or 0.005 REF (1) |  |  |
| D | 1.70 | 1.80 | 1.90 | 0.067 | 0.071 | 0.075 |
| E | 1.30 | 1.40 | 1.50 | 0.051 | 0.055 | 0.059 |
| e | 0.40 BSC |  |  | 0.016 BSC |  |  |
| L | 0.35 | 0.40 | 0.45 | 0.014 | 0.016 | 0.018 |
| L1 | 0.45 | 0.50 | 0.55 | 0.0177 | 0.0197 | 0.0217 |

Note
${ }^{(1)}$ The dimension depends on the leadframe that assembly house used.

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ECN T16-0163-Rev. B, 16-May-16
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DWG: 5957

RECOMMENDED MINIMUM PADS FOR MINI QFN 10L


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